

**Search Notes**

Application/Control No.

10/760,651

Examiner

Raymond Phan

Applicant(s)/Patent under  
Reexamination

TIERNEY ET AL.

Art Unit

2111

**SEARCHED**

Class	Subclass	Date	Examiner
710	309-315, 105-107, 110-112	3/20/2007	RP
710	240-244	3/21/2007	RP
711	136-146	3/21/2007	RP

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST	3/21/2007	RP